

<b>Notice of References Cited</b>	Application/Control No. 10/577,702	Applicant(s)/Patent Under Reexamination YANAGAWA ET AL.	
	Examiner Rip A. Lee	Art Unit 1713	Page 1 of 1


**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-3,900,452	08-1975	Valvassori et al.	526/139
	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	SU 1690365 A1	11-1992	Soviet Union	Khotimskii et al.	C08F 138/00
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**NON-PATENT DOCUMENTS**

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*	U	Andes et al. J. Am. Chem. Soc. 2001, 123, 7423-7424.
	V	SU 1690365 (abstract in English)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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